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ON Semiconductor®

# **FQD9N25 / FQU9N25**

## N-Channel QFET® MOSFET

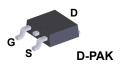
**250** V, +.4 A, ( &\$ a  $\Omega$ 

### **Description**

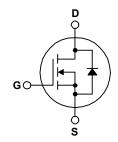
This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 7.4 A, 250 V,  $R_{DS(on)}$  = 420 m $\Omega$  (Max.) @ $V_{GS}$  = 10 V,  $I_D$  = 3.7 A
- Low Gate Charge (Typ. 15.5 nC)
- Low Crss (Typ. 15 pF)
- · 100% Avalanche Tested







## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter		FQD9N25TM FQD9N25TM-F080 FQU9N25TU	Unit	
V <sub>DSS</sub>	Drain-Source Voltage		250	V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	(C)	7.4	Α	
	- Continuous (T <sub>C</sub> = 100	)°C)	4.7	А	
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	29.6	А	
$V_{GSS}$	Gate-Source Voltage		± 30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	165	mJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	7.4	А	
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		5.5	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns	
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W	
	Power Dissipation (T <sub>C</sub> = 25°C)		55	W	
	- Derate above 25°C		0.44	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

#### **Thermal Characteristics**

Symbol	Parameter	FQD9N25TM FQD9N25TM-F080 FQU9N25TU	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	2.27	
В	Thermal Resistance, Junction to Ambient (minimum pad of 2 oz copper), Max.	110	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (*1 in² pad of 2 oz copper), Max.	50	

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQD9N25TM	FQD9N25	D-PAK	Tape and Reel	330 mm	16 mm	2500 units
FQD9N25TM-F080	FQD9N25	D-PAK	Tape and Reel	330 mm	16 mm	2500 units
FQU9N25TU	FQU9N25	I-PAK	Tube	N/A	N/A	70 units

# **Electrical Characteristics** $T_{\rm C}$ = 25°C unless otherwise noted.

	Parameter	Test Conditions		Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	250			V
$\Delta BV_{DSS}$ / $\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.2		V/°C
I <sub>DSS</sub>		V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V		-	1	μΑ
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 200 V, T <sub>C</sub> = 125°C		-	10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V		-	100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V		ı	-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3.0		5.0	V
	Static Drain-Source	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.7 A		0.33	0.42	Ω
R <sub>DS(on)</sub>	On-Resistance	00 , 5				
9 <sub>FS</sub>	On-Resistance Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 3.7 A		6.8		S
g <sub>FS</sub>	Forward Transconductance ic Characteristics	00 12		6.8		
g <sub>FS</sub> <b>Dynam</b> C <sub>iss</sub>	Forward Transconductance  ic Characteristics  Input Capacitance	00 12		540	700	pF
g <sub>FS</sub> <b>Dynam</b> C <sub>iss</sub> C <sub>oss</sub>	Forward Transconductance ic Characteristics	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 3.7 A				pF
g <sub>FS</sub> <b>Dynam</b> C <sub>iss</sub>	Forward Transconductance  ic Characteristics  Input Capacitance	$V_{DS} = 50 \text{ V}, I_{D} = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		540	700	pF pF
9FS  Dynam  C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	ic Characteristics Input Capacitance Output Capacitance	$V_{DS} = 50 \text{ V}, I_{D} = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		540 110	700 145	pF pF
g <sub>FS</sub> Dynam  C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switchi	ic Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 50 \text{ V}, I_{D} = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		540 110	700 145	pF pF pF
9FS  Dynam  C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	ic Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance ing Characteristics	$V_{DS} = 50 \text{ V}, I_D = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$ $V_{DD} = 125 \text{ V}, I_D = 9.4 \text{ A},$		540 110 15	700 145 20	pF pF pF
$\begin{array}{c} g_{FS} \\ \hline \textbf{Dynam} \\ C_{iss} \\ C_{oss} \\ C_{rss} \\ \hline \textbf{Switchi} \\ t_{d(on)} \\ t_{r} \\ \end{array}$	Forward Transconductance  ic Characteristics  Input Capacitance  Output Capacitance  Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time	$V_{DS} = 50 \text{ V}, I_{D} = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		540 110 15	700 145 20 35	pF pF pF
g <sub>FS</sub> Dynam  C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switchi  t <sub>d(on)</sub>	ic Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time	$V_{DS} = 50 \text{ V}, I_D = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$ $V_{DD} = 125 \text{ V}, I_D = 9.4 \text{ A},$		540 110 15 13 105	700 145 20 35 220	pF pF pF
$\begin{array}{c} g_{FS} \\ \hline \textbf{Dynam} \\ C_{iss} \\ C_{oss} \\ C_{rss} \\ \hline \textbf{Switchi} \\ t_{d(on)} \\ t_{r} \\ \hline t_{d(off)} \\ \end{array}$	Forward Transconductance  ic Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance  ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$V_{DS} = 50 \text{ V}, I_D = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$ $V_{DD} = 125 \text{ V}, I_D = 9.4 \text{ A},$ $R_G = 25 \Omega$		540 110 15 13 105 25	700 145 20 35 220 60	
$\begin{array}{c} g_{FS} \\ \hline \textbf{Dynam} \\ C_{iss} \\ C_{oss} \\ C_{rss} \\ \hline \textbf{Switchi} \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ \end{array}$	Forward Transconductance  ic Characteristics  Input Capacitance  Output Capacitance  Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time	$V_{DS} = 50 \text{ V}, I_D = 3.7 \text{ A}$ $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$ $V_{DD} = 125 \text{ V}, I_D = 9.4 \text{ A},$ $R_G = 25 \Omega$ (Note 4)	  	540 110 15 13 105 25 45	700 145 20 35 220 60 100	pF pF pF ns ns

I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				7.4	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				29.6	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 7.4 A			1.5	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 9.4 A,		150		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> / dt = 100 A/μs		0.8		μС

- Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 4.8 mH,  $I_{AS}$  = 7.4 A,  $V_{DD}$  = 50 V,  $R_C$  = 25  $\Omega$ , Starting  $T_J$  = 25°C 3.  $I_{SD}$  ≤ 9.4 A, di/dt ≤ 300 A/ $\mu$ s,  $V_{DD}$  ≤ BV $_{DSS}$ , Starting  $T_J$  = 25°C 4. Essentially independent of operating temperature

# **Typical Characteristics**

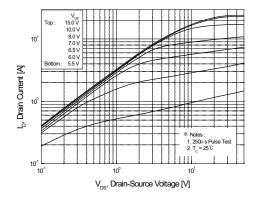


Figure 1. On-Region Characteristics

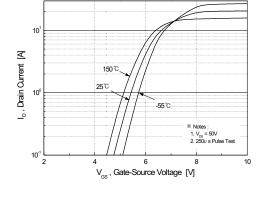


Figure 2. Transfer Characteristics

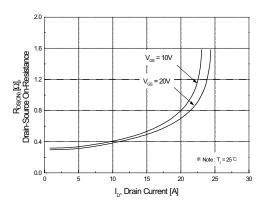


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

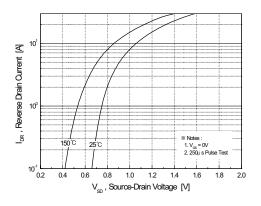


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

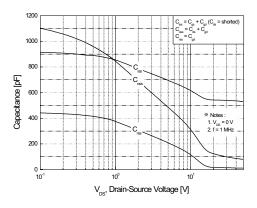


Figure 5. Capacitance Characteristics

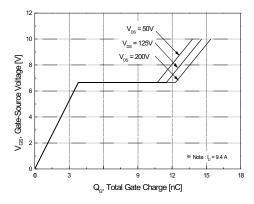


Figure 6. Gate Charge Characteristics

# Typical Characteristics (Continued)

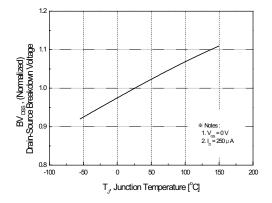


Figure 7. Breakdown Voltage Variation vs. Temperature

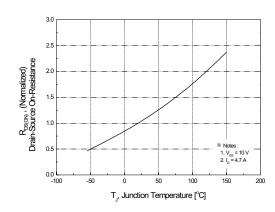


Figure 8. On-Resistance Variation vs. Temperature

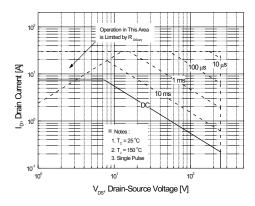


Figure 9. Maximum Safe Operating Area

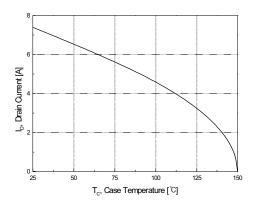


Figure 10. Maximum Drain Current vs. Case Temperature

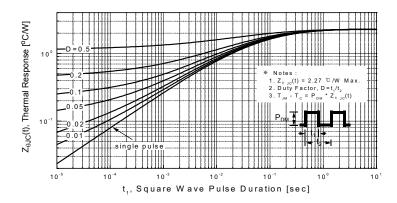


Figure 11. Transient Thermal Response Curve

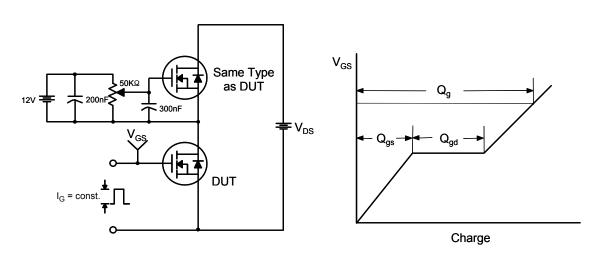


Figure 12. Gate Charge Test Circuit & Waveform

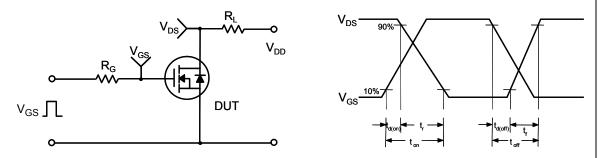


Figure 13. Resistive Switching Test Circuit & Waveforms

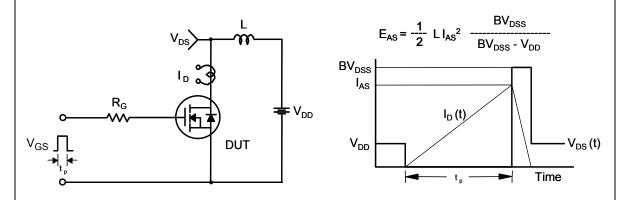
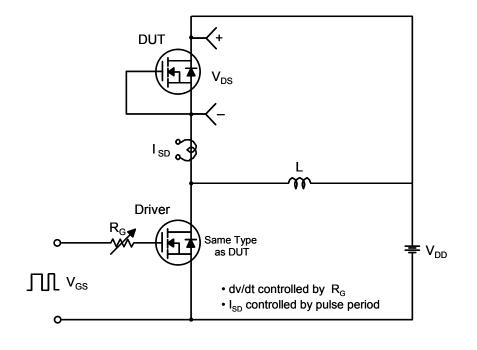


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



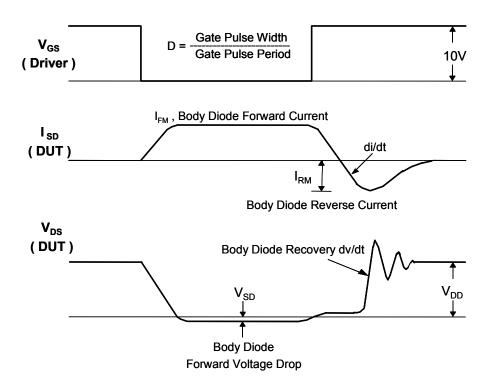


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

#### **Mechanical Dimensions**

# TO-252 3L (DPAK) FQD9N25TM

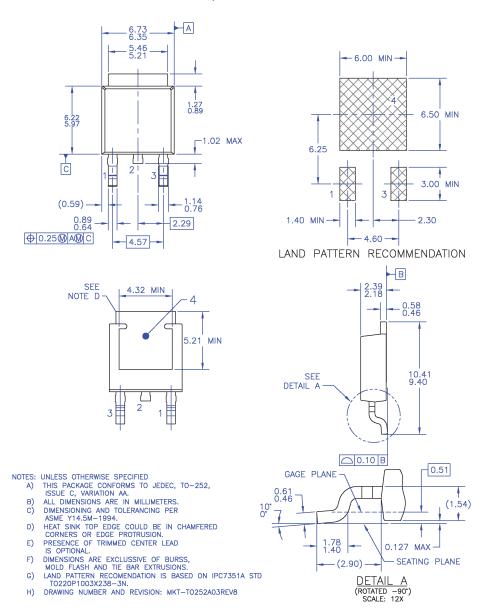


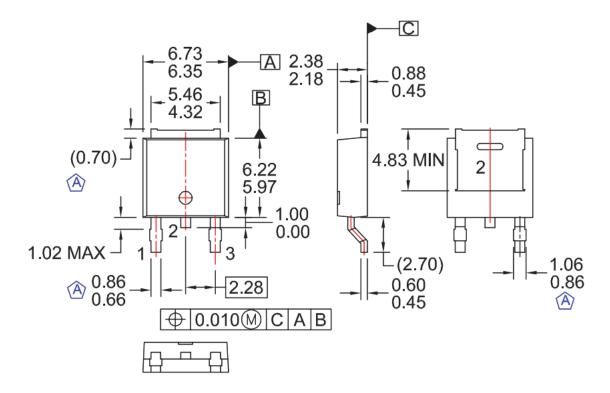
Figure 16. TO252 (D-PAK), Molded, 3 Lead, Option AA&AB

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Dimension in Millimeters

#### **Mechanical Dimensions**

# TO-252 3L (DPAK) FQD9N25TM\_F080



NOTES: UNLESS OTHERWISE SPECIFIED

(A) CONFORMS TO JEDEC TO-252 VARIATION AB
EXCEPT WHERE NOTED

- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DRAWING CONFORMS TO ASME Y14.5M-1994
- D) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- E) FORMERLY NAMED BD1733
- F) DRAWING FILE NAME: MKT-TO252D03REV1

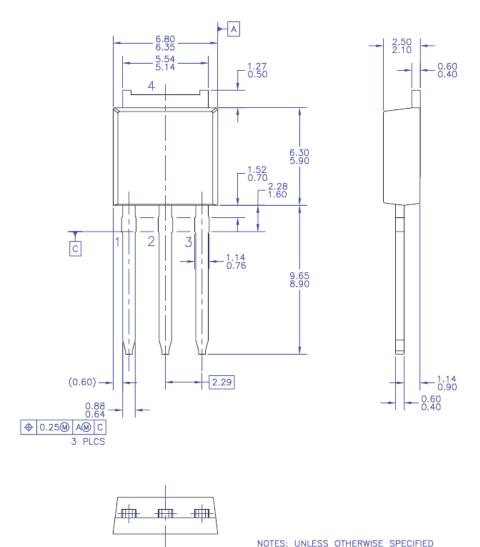
Figure 17. 3LD, TO-252, Jedec TO-252 VAR. AB, Surface Mount

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Dimension in Millimeters

#### **Mechanical Dimensions**

# TO-251 3L (IPAK)



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  - DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

#### Figure 18. TO251 (IPAK) Molded 3 Lead

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Dimension in Millimeters

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